

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.

P7318-9007

Sh et 1 of 1

SERIAL NO.

New Application

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT

NAKAMURA et al.

EXAMINER

FILING DATE

August 16, 1999

GROUP

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
	AB						
	AC						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION	
							YES	NO
Q2	AD	57-59721	04/10/82	Japan	Abstract Only		X	X
	AE	60-34834	02/22/85	Japan	Abstract Only		X	X
	AF	7-84034	09/13/95	Japan	Abstract Only		X	X
	AG	49-53264	05/23/74	Japan	No abstract No translation			X
	AH	49-107069	10/11/74	Japan	"			X
	AI	53-41375	04/14/78	Japan	"			X
	AJ	3-138135	06/12/91	Japan	"			X
Q2	AK	54-106583	08/21/79	Japan	"			X
	AL							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AM	
	AN	
	AO	

EXAMINER

JH JW

DATE CONSIDERED

3/6/03

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JES72 U.S. PTO

09/931763

08/20/01

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. P107318-09007	SERIAL NO. 09/355,976
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)		APPLICANT NAKAMURA et al.	EXAMINER
		FILING DATE August 16, 1999	GROUP 1734

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
qr	AA	3,201,302	08/17/65	WILLIAMS et al.			
	AB	3,188,258	06/08/65	YOUNG			
	AC	3,442,737	05/06/69	REED et al.			
	AD	4,871,499	10/03/89	AUDOUX et al.			
	AE	5,503,923	04/02/96	GOTO et al.			
qr	AF	4,872,930	10/10/89	KAJIKAWA et al.			

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO	
qr	AG	1,118,597	07/03/68	Great Britain			X	
	AH	0365112A2	04/25/90	Europe			X	
	AI	6-340849	12/13/94	Japan <i>Abstract Only</i>			X	X
	AJ	EP0737731A2	10/16/96	Europe			X	
qr	AK	7-214734	08/15/95	Japan <i>Abstract Only</i>			X	X
	AL							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER <i>John JW</i>	DATE CONSIDERED <i>3/6/03</i>
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